IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant:

COOK, et al

Serial No:

10/035659

Filed:

10/26/2001

For:

DIRECT BONDING OF GLASS ARTICLES FOR DRAWING

Examiner: John Hoffman

Group Art Unit: 1731

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT UNDER 37 C.F.R. §§ 1.56, 1.97 – 1.98

Commissioner of Patents Alexandria, VA 22313-1450

Dear Sir:

The Examiner's attention is hereby directed to the following reference(s) listed on the attached Form PTO-1449 for consideration in connection with the examination of the above-identified patent application. One copy of the reference(s) is enclosed, except any US Patents.

This submission does not represent that a search has been made or that no better art exists and does not constitute an admission that each or all of the enclosed documents constitute "prior art." If it should be determined that any of the submitted documents do not constitute "prior art" under United States law, applicant(s) reserve the right to present to the office the relevant facts and law regarding the appropriate status of such documents.

Applicant(s) further reserve the right to take appropriate action to establish the patentability of the disclosed invention over the enclosed references, should one or more of the references be applied against the claims of the present application.

The undersigned attorney is granted limited recognition by the Office of Discipline and Enrollment of the USPTO to practice before the USPTO in capacity as an employee of Corning Incorporated. A copy of the document granting such limited recognition either has been previously submitted or is submitted herewith for the record.

Please direct any questions or comments to the undersigned at (607) 248-1253.

Respectfully submitted,

Siwen Chen

Corning Incorporated

SP-TI-03-1

Corning, NY 14831

607-248-1283

Date: Harray 22, 2005

I hereby certify that this correspondence is being deposited with the United States Postal Service as first class mail in an envelope addressed to Commissioner of Patents, Alexandria, VA 22313-1450 on

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Signature: Jennifer Kazyki

FORM PTO-1449 (MODIFIED)

ATTORNEY DOCKET NO.

SERIAL NO.

LIST OF PATENTS AND PUBLICATIONS

SP01-302

10/035659

FOR APPLICANTS INFORMATION DISCLOSURE STATEMENT E

APPLICANT: COOK, et al.

FILING DATE 10/26/2001

GROUP: 1731

REFERENCE DESIGNATION.

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Examiner		Document	Date	Name	Class	Sub- Class	Filing Dat if Approp
Initial	AA	Number 4,186,999	2/5/80	Harwood et al	350	96.21	
	AB	4,530,452	7/23/85	Balyasny et al	225	96	
	AC	4,626,068	12/2/86	Caldwell	350	96.34	
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	AF	5,451,547	9/19/95	Himi et al	437	225	
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	BJ	6,129,854	10/10/00	Ramsey et al.	216	18	<u> </u>
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E	ЗХ	ONISHI et al., "A novel temperature compensation method for SAW devices using direct bonding Techniques," <i>Ultrasonics Symp</i> , 1997, IEEE Proceedings, 5-8 Oct, 1997
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E	3Y	Arthur Landrock; "Surface Preparation of Adherends"; Adhesives Technology Handbook; 1985; page 117-118
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	CG	

EXAMINER:

DATE CONSIDERED:

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609: draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.